

**Search Notes****Application/Control No.**

10/003,831

**Examiner**

Aaron W. Carter

**Applicant(s)/Patent under Reexamination**

NAKANO ET AL.

**Art Unit**

2625

**SEARCHED**

Class	Subclass	Date	Examiner
382	141 - 152		
438	16		
348	87		
29	833	4/05	AWC
438	5,14,400		
257	E23.179		
250	559.01 - 559.03		
356	237.1 - 237.6		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST CLASS & TEXT SEARCH	4/05	AWC
IEEE SEARCH	04/05	AWC
INVENTOR NAME SEARCH	4/05	AWC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner